

Search Notes

Application/Control No.

10/823,170

Examiner

Yonel Beaulieu

Applicant(s)/Patent under
Reexamination

NAIK ET AL.

Art Unit

3661

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 701 | 1 | 1/18/2007 | YB |
| | 29 | | |
| | 34 | | |
| | 36 | | |
| 702 | 108 | | |
| | 127 | | |
| 714 | 735 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| WEST | 1/19/2007 | YB |
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